MOSFET – Power, P-Channel, Schottky Diode, Schotty Barrier Diode, FETKY, DFN6

-20 V, -3.9 A, 2.0 A

Features

- Flat Lead 6 Terminal Package 3x3x1 mm
- Enhanced Thermal Characteristics
- Low VF and Low Leakage Schottky Diode
- Reduced Gate Charge to Improve Switching Response
- This is a Pb-Free Device

Applications

- Buck Converter
- High Side DC-DC Conversion Circuits
- Power Management in Portable, HDD and Computing

MOSFET MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	V_{DSS}	-20	V		
Gate-to-Source Voltage	9		V_{GS}	±12	V
Continuous Drain	Steady	T _A = 25°C	I _D	-2.7	Α
Current (Note 1)	State	T _A = 85°C		-2.0	
	t ≤ 10 s	T _A = 25°C		-3.9	
Power Dissipation (Note 1)	Steady State T _A = 25°C		P _D	1.6	W
	t ≤ 10 s			3.0	
Continuous Drain		T _A = 25°C	I _D	-2.3	Α
Current (Note 2)	Steady	T _A = 85°C		-1.7	
Power Dissipation (Note 2)	State	T _A = 25°C	P _D	1.14	W
Pulsed Drain Current	t _p =	10 μs	I _{DM}	11	Α
Operating Junction and	T _J , T _{STG}	–55 to 150	°C		
Source Current (Body D	I _S	1.1	Α		
Lead Temperature for S (1/8" from case for 10 s)		urposes	T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.5 in sq).



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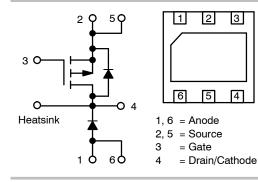
http://onsemi.com

MOSFET

V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
-20 V	110 mΩ @ –4.5 V	-3.9 A

SCHOTTKY DIODE

V _R MAX	V _F TYP	I _F MAX
20 V	0.36 V	2.0 A



MARKING DIAGRAMS



DFN6 CASE 506AH



3402 = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
■ Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NTLGF3402PT1G	DFN6 (Pb-Free)	3000 / Tape & Reel
NTLGF3402PT2G	DFN6 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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SCHOTTKY DIODE MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Max	Unit
Peak Repetitive Reverse Voltage	V_{RRM}	20	V
DC Blocking Voltage	V_{R}	20	V
Average Rectified Forward Current	l _F	2.0	Α

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 2)	$R_{ hetaJA}$	110	°C/W
Junction-to-Ambient – t ≤ 10 s (Note 2)	$R_{ hetaJA}$	58	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	79	°C/W
Junction-to-Ambient – t ≤ 10 s (Note 3)	$R_{ hetaJA}$	41	°C/W

^{3.} Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -25$	50 μA	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				-9.0		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}		T _J = 25°C			-1.0	μΑ
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$	T _J = 125°C			-5.0	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±	12 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = -2$	50 μΑ	-0.6		-2.0	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				2.7		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = -4.5, I _D = -2.7 A			110	140	mΩ
		V _{GS} = -2.5, I _D = -	1.0 A		190	225	1
Forward Transconductance	9 _{FS}	$V_{DS} = -10 \text{ V}, I_D = -2.7 \text{ A}$			4.8		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = -10 V			230	350	pF
Output Capacitance	C _{OSS}				105	225	1
Reverse Transfer Capacitance	C _{RSS}	100 11			40	75	1
Total Gate Charge	Q _{G(TOT)}				3.8	10	nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_D = -2.7 \text{ A}$			0.32		1
Gate-to-Source Charge	Q_{GS}				0.7		1
Gate-to-Drain Charge	Q_{GD}				1.6		1
SWITCHING CHARACTERISTICS (No	ote 5)						
Turn-On Delay Time	t _{d(ON)}				6.2	15	ns
Rise Time	t _r	V _{GS} = -4.5 V, V _{DD} =	–16 V,		22	30	1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = -2.7 \text{ A}, R_G = 2$	2.4 Ω		25	45	1
	1	1			1	1	1

^{4.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.

Fall Time

60

^{5.} Switching characteristics are independent of operating junction temperatures.

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = -1.1 \text{ A}$	T _J = 25°C		-0.8	-1.2	٧
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } I_{S} = -1.1 \text{ A ,} \\ dI_{S}/dt = 100 \text{ A/}\mu\text{s}$			53		ns
Charge Time	t _a				15		
Discharge Time	t _b				38		
Reverse Recovery Charge	Q _{RR}				37		nC

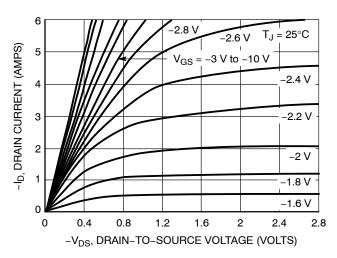
SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Maximum Instantaneous	V _F	I _F = 0.1 A		0.32	0.34	V
Forward Voltage		I _F = 1.0 A		0.36	0.39	
Maximum Instantaneous Reverse Current	I _R	V _R = 5 V, T _J = 100°C			12	mA
Heverse Current		V _R = 10 V		70		μΑ
		V _R = 20 V		225		

^{6.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
7. Switching characteristics are independent of operating junction temperatures.

TYPICAL P-CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)



V_{DS} ≥ -10 V

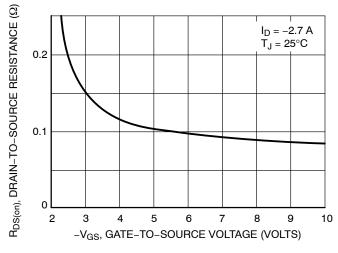
T_J = -55°C

1 1.5 2 2.5 3 3.5 4

-V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



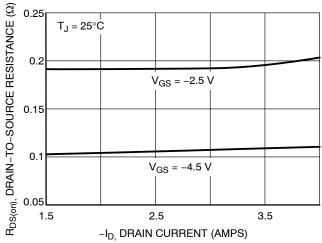
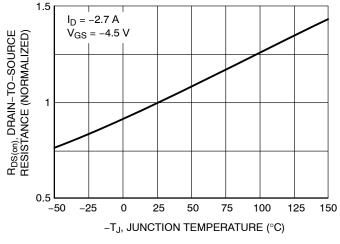


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



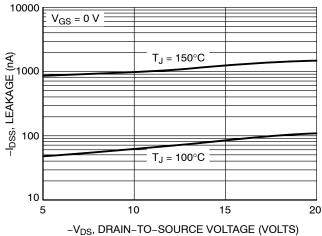
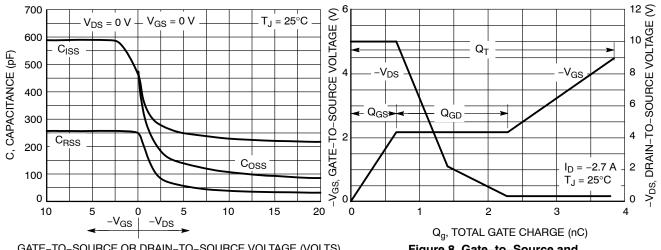


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL P-CHANNEL PERFORMANCE CURVES

(T_{.1} = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

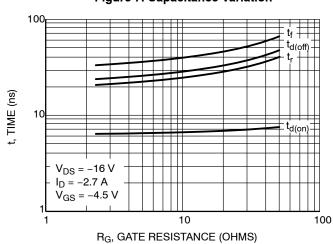


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

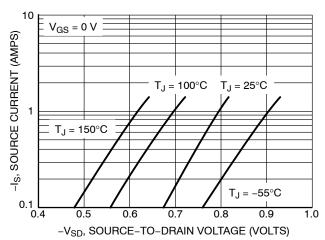


Figure 10. Diode Forward Voltage vs. Current

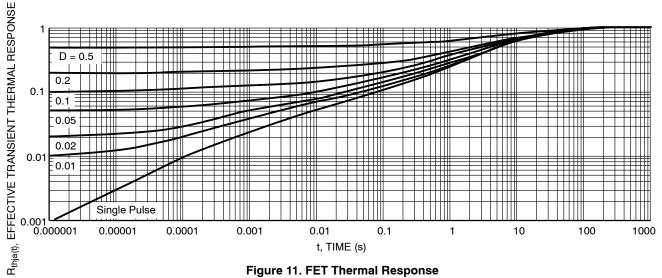
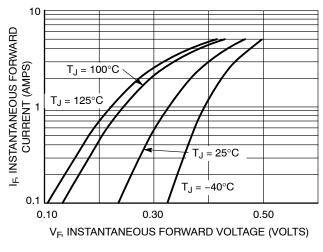


Figure 11. FET Thermal Response

TYPICAL SCHOTTKY PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)



OBANARO OSO OSO OSO VE MAXIMUM INSTANTANEOUS FORWARD VOLTAGE (VOLTS)

Figure 12. Typical Forward Voltage

Figure 13. Maximum Forward Voltage

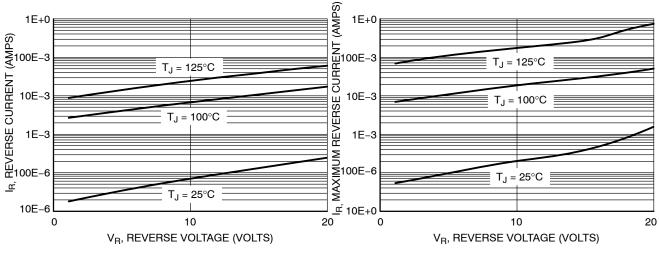
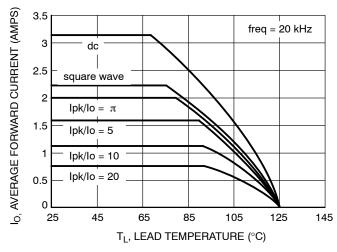


Figure 14. Typical Reverse Current

Figure 15. Maximum Reverse Current





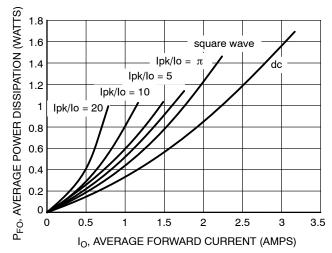


Figure 17. Forward Power Dissipation

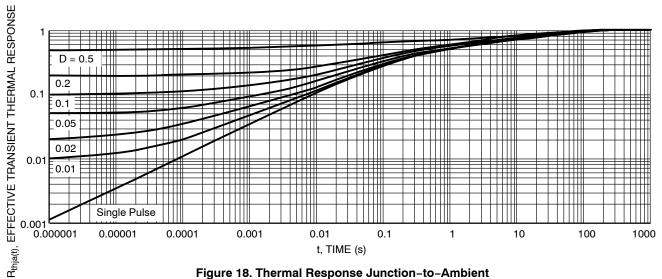
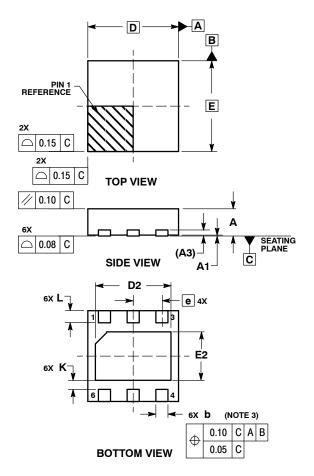


Figure 18. Thermal Response Junction-to-Ambient

PACKAGE DIMENSIONS

DFN6 3*3 MM, 0.95 PITCH

CASE 506AH-01 **ISSUE O**

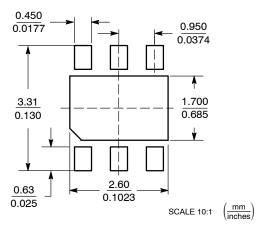


NOTES:

- 1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
- DIMESNION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS						
DIM	MIN	MIN NOM MAX					
Α	0.80	0.90	1.00				
A1	0.00	0.03	0.05				
А3	0	.20 REF					
b	0.35 0.40 0.45						
D	3	3.00 BSC					
D2	2.40	2.50	2.60				
E	3	.00 BSC	;				
E2	1.50	1.60	1.70				
е	0	0.95 BSC					
K	0.21						
L	0.30	0.40	0.50				

SOLDERING FOOTPRINT*



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